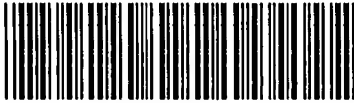


Search Notes

Application/Control No.

10/540,612

Examiner

Jae W. Lee, Ph.D.

Applicant(s)/Patent under
Reexamination

FARNEGARDH ET AL.

Art Unit

1656

SEARCHED

Class	Subclass	Date	Examiner
NONE	NONE	11/15/2007	JWL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN databases: BIOSIS, CAPLUS, EMBASE, MEDLINE, SCISEARCH, AND JPIO, see attached search history printouts	11/15/2007	JWL
See search results available by SCORE	11/15/2007	JWL